

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/912,574 KIM ET AL.	
		Examiner	Art Unit Benny Q. Tieu	2642 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,818,824	10-1998	Lu et al.	370/328
	B	US-6,047,176	04-2000	Sakamoto et al.	455/422.1
	C	US-6,351,649	02-2002	Watanabe et al.	455/501
	D	US-6,493,550	12-2002	Raith, Alex Krister	455/422.1
	E	US-6,539,237	03-2003	Sayers et al.	455/555
	F	US-2003/0036409	02-2003	Sato et al.	455/561
	G	US-2001/0046860	11-2001	Lee, Dong-Youl	455/426
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.